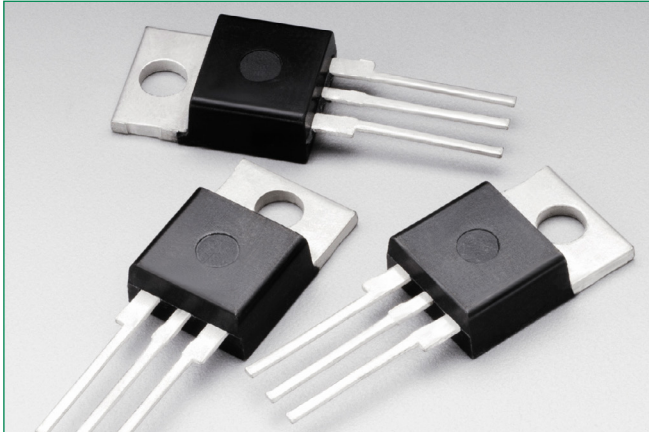


# MAC8SDG, MAC8SMG, MAC8SNG

Surface Mount – 50V



## Additional Information



Resources



Accessories



Samples

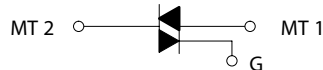
## Description

Designed for industrial and consumer applications for full wave control of ac loads such as appliance controls, heater controls, motor controls, and other power switching applications. The MAC8SxG is designed for industrial and consumer applications for full wave control of ac loads such as appliance controls, heater controls, motor controls, and other power switching applications.

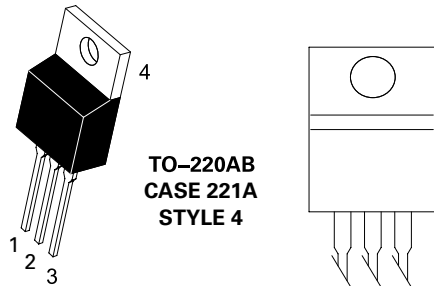
## Features

- Sensitive Gate Allows Triggering by Microcontrollers and other Logic Circuits
- Uniform Gate Trigger Currents in Three Quadrants; Q1, Q2, and Q3
- High Immunity to  $dv/dt$  – 25 V/ $\mu$ s Minimum at 110°C
- High Commutating  $di/dt$  – 8.0 A/ms Minimum at 110°C
- Maximum Values of  $I_{GT}$ ,  $V_{GT}$  and  $I_H$  Specified for Ease of Design
- On-State Current Rating of 8 Amperes RMS at 70°C
- High Surge Current Capability – 70 Amperes
- Blocking Voltage to 800 Volts
- Rugged, Economical TO-220 Package
- These Devices are Pb-Free and are RoHS Compliant

## Functional Diagram



## Pin Out



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### Maximum Ratings (T<sub>J</sub> = 25°C unless otherwise noted)

| Rating  | Symbol                        | Value                                 | Unit               |   |
|---|-------------------------------|---------------------------------------|--------------------|---|
| Peak Repetitive Off-State Voltage (Note 1)<br>(Gate Open, Sine Wave 50 to 60 Hz, T <sub>J</sub> = 25° to 110°C) | MAC8SDG<br>MAC8SMG<br>MAC8SNG | V <sub>DRM'</sub><br>V <sub>RRM</sub> | 400<br>600<br>800  | V |
| On-State RMS Current (Full Cycle Sine Wave, 60 Hz, T <sub>C</sub> = 70°C)                                       | I <sub>T (RMS)</sub>          | 8.0                                   | A                  |   |
| Peak Non-Repetitive Surge Current<br>(One Full Cycle Sine Wave, 60 Hz, T <sub>J</sub> = 110°C)                  | I <sub>TSM</sub>              | 70                                    | A                  |   |
| Circuit Fusing Consideration (t = 8.3 ms)   | I <sup>2</sup> t              | 20                                    | A <sup>2</sup> sec |   |
| Peak Gate Power (Pulse Width ≤ 1.0 μs, T <sub>C</sub> = 70°C)   | P <sub>GM</sub>               | 16                                    | W                  |   |
| Average Gate Power (t = 8.3 ms, T <sub>C</sub> = 70°C)  | P <sub>G(AV)</sub>            | 0.35                                  | W                  |   |
| Operating Junction Temperature Range  | T <sub>J</sub>                | -40 to +110                           | °C                 |   |
| Storage Temperature Range   | T <sub>stg</sub>              | -40 to +150                           | °C                 |   |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- V<sub>DRM'</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

### Thermal Characteristics

| Rating   | Symbol                               | Value       | Unit |
|--|--------------------------------------|-------------|------|
| Thermal Resistance,<br>Junction-to-Case (AC)<br>Junction-to-Ambient            | R <sub>θJC</sub><br>R <sub>θJA</sub> | 2.2<br>62.5 | °C/W |
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds | T <sub>L</sub>                       | 260         | °C   |

### Electrical Characteristics - OFF (T<sub>J</sub> = 25°C unless otherwise noted ; Electricals apply in both directions)

| Characteristic   | Symbol                                | Min | Typ | Max  | Unit |
|--|---------------------------------------|-----|-----|------|------|
| Peak Repetitive Blocking Current<br>(V <sub>D</sub> = V <sub>DRM'</sub> = V <sub>RRM'</sub> ; Gate Open) | I <sub>DRM'</sub><br>I <sub>RRM</sub> | -   | -   | 0.01 | mA   |
|  |                                       | -   | -   | 2.0  |      |

### Electrical Characteristics - ON (T<sub>J</sub> = 25°C unless otherwise noted; Electricals apply in both directions)

| Characteristic   | Symbol          | Min  | Typ  | Max  | Unit |
|--|-----------------|------|------|------|------|
| Peak On-State Voltage (Note 4) (I <sub>TM</sub> = ±11 A)                                   | V <sub>TM</sub> | -    | -    | 1.85 | V    |
| Gate Trigger Current<br>(Continuous dc)<br>(V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 Ω) | MT2(+), G(+)    | -    | 2.0  | 5.0  | mA   |
|  | MT2(+), G(-)    | -    | 3.0  | 5.0  |      |
|  | MT2(-), G(-)    | -    | 3.0  | 5.0  |      |
| Holding Current (V <sub>D</sub> = 12 V, Gate Open, Initiating Current = ±150 mA)           | I <sub>H</sub>  | -    | 3.0  | 10   | mA   |
| Latching Current<br>(V <sub>D</sub> = 24 V, I <sub>G</sub> = 5 mA)                         | MT2(+), G(+)    | -    | 5.0  | 15   | mA   |
|  | MT2(+), G(-)    | -    | 10   | 20   |      |
|  | MT2(-), G(-)    | -    | 5.0  | 15   |      |
| Gate Trigger Voltage<br>(V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 Ω)                    | MT2(+), G(+)    | 0.45 | 0.62 | 1.5  | V    |
|  | MT2(+), G(-)    | 0.45 | 0.60 | 1.5  |      |
|  | MT2(-), G(-)    | 0.45 | 0.65 | 1.5  |      |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- Indicates Pulse Test: Pulse Width ≤ 2.0 ms, Duty Cycle ≤ 2%.

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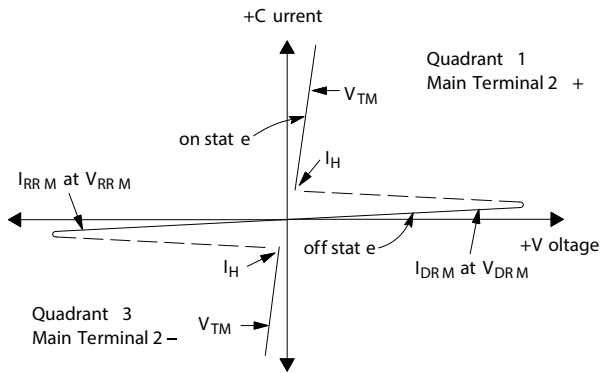
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## Dynamic Characteristics

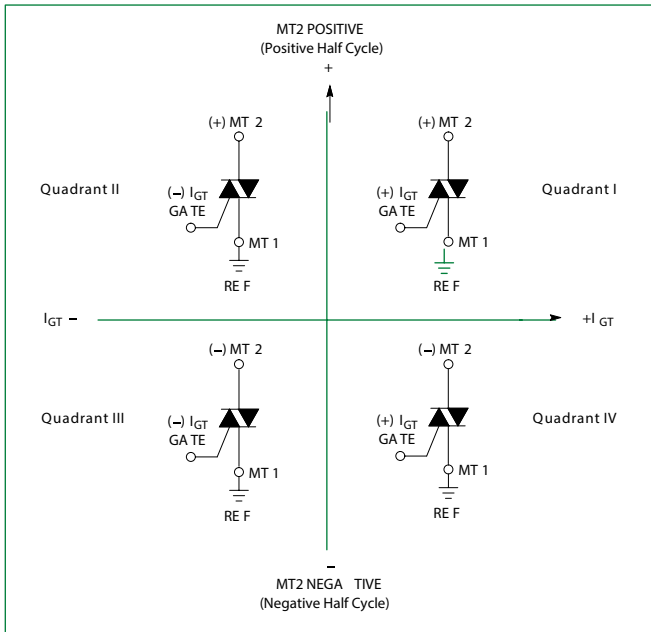
| Characteristic   | Symbol        | Min | Typ | Max | Unit             |
|--|---------------|-----|-----|-----|------------------|
| Rate of Change of Commutating Current See Figure 10.<br>( $V_D = 400\text{ V}$ , $I_{TM} = 3.5\text{ A}$ , Commutating $dv/dt = 10\text{ V}/\mu\text{s}$ , Gate Open, $T_J = 110^\circ\text{C}$ , $f = 500\text{ Hz}$ , Snubber), $C_S = 0.01\ \mu\text{F}$ , $R_S = 15\ \Omega$ ) | $di/dt_{(C)}$ | 8.0 | 10  | –   | A/ms             |
| Critical Rate of Rise of Off-State Voltage<br>( $V_D = \text{Rated } V_{DRM}$ , Exponential Waveform, $R_{GK} = 510\ \Omega$ , $T_J = 110^\circ\text{C}$ )   | $dV/dt$       | 25  | 75  | –   | V/ $\mu\text{s}$ |

## Voltage Current Characteristic of SCR

| Symbol    | Parameter                                 |
|-----------|---|
| $V_{DRM}$ | Peak Repetitive Forward Off State Voltage |
| $I_{DRM}$ | Peak Forward Blocking Current             |
| $V_{RRM}$ | Peak Repetitive Reverse Off State Voltage |
| $I_{RRM}$ | Peak Reverse Blocking Current             |
| $V_{TM}$  | Maximum On State Voltage                  |
| $I_H$     | Holding Current                           |



## Quadrant Definitions for a Triac



All polarities are referenced to MT1.  
With in-phase signals (using standard AC lines) quadrants I and III are used

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Figure 1. RMS Current Derating

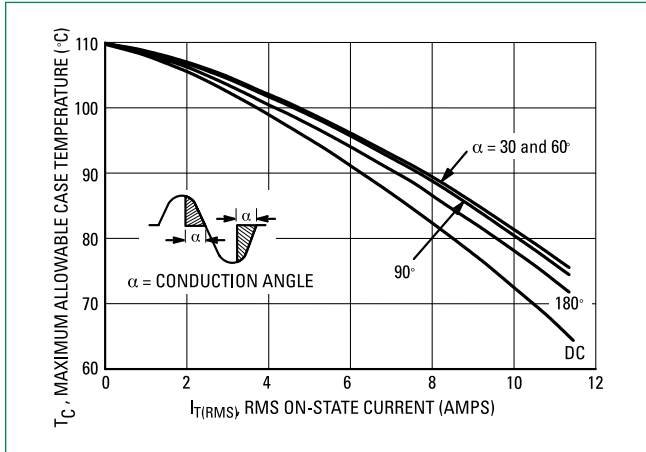


Figure 2. Maximum On-State Power Dissipation

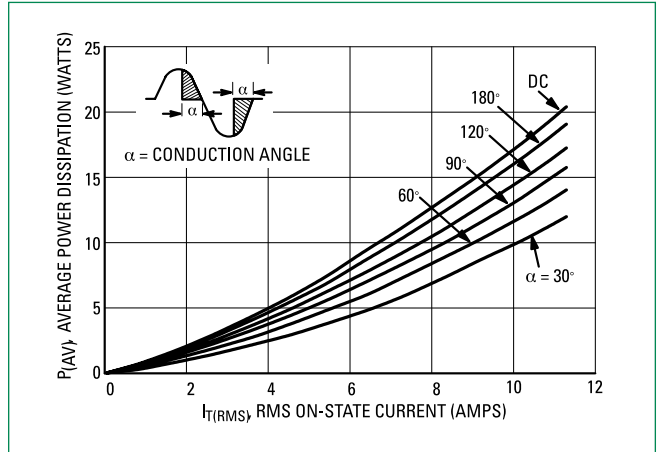


Figure 3. On-State Characteristics

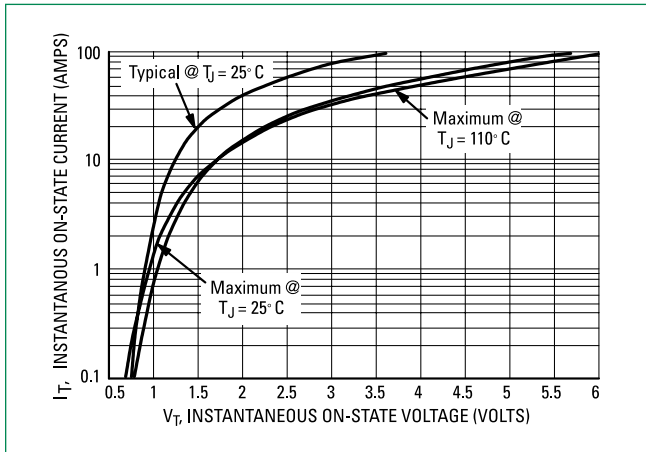


Figure 4. Transient Thermal Response

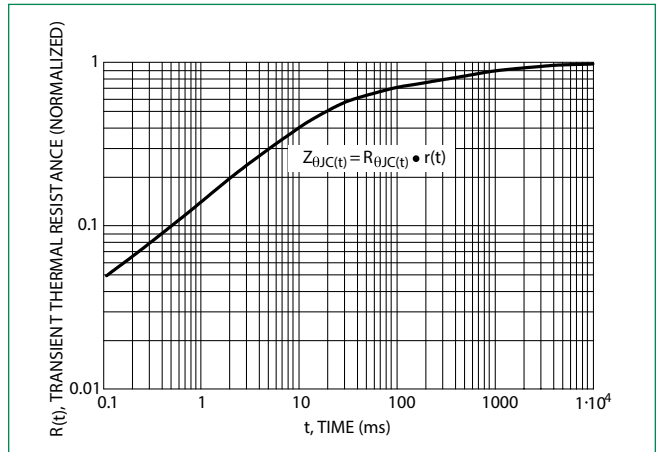


Figure 5. Typical Holding Current Vs. Junction Temperature

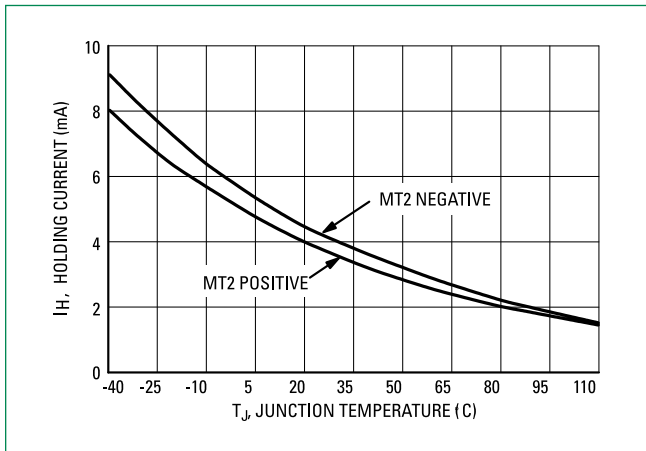
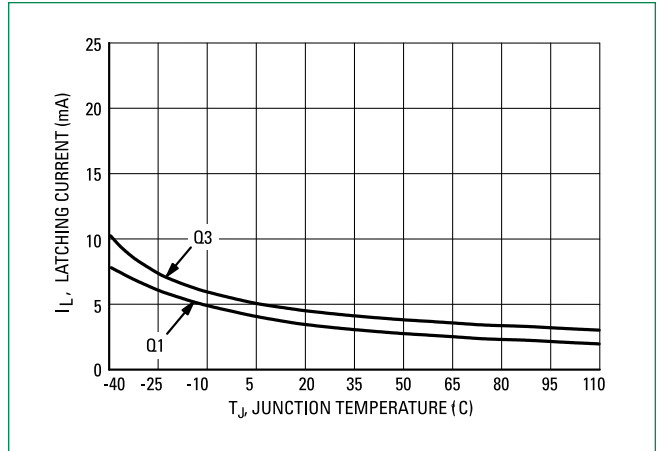


Figure 6. Typical Latching Current Vs. Junction Temperature



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Figure 7. Typical Gate Trigger Current Vs. Junction Temperature

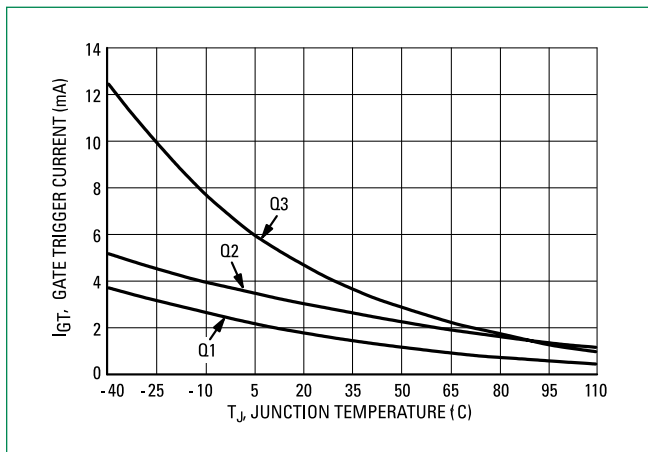


Figure 8. Typical Gate Trigger Voltage Vs. Junction Temperature

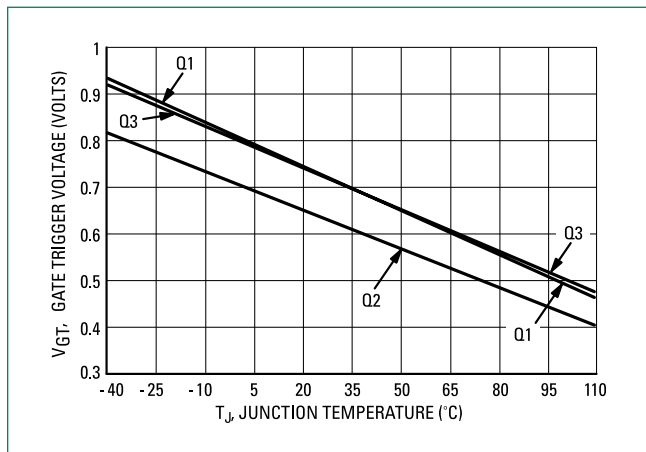


Figure 9. Typical Exponential Static dv/dt Vs. Gate-MT1 Resistance, MT2(+)

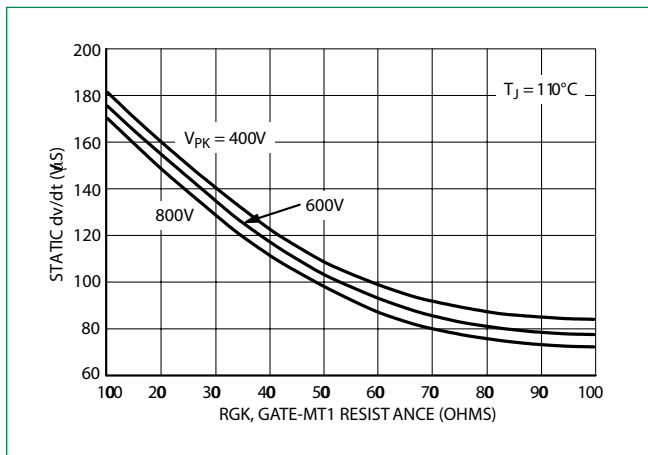


Figure 10. Typical Exponential Static dv/dt Versus Peak Voltage, MT2(+)

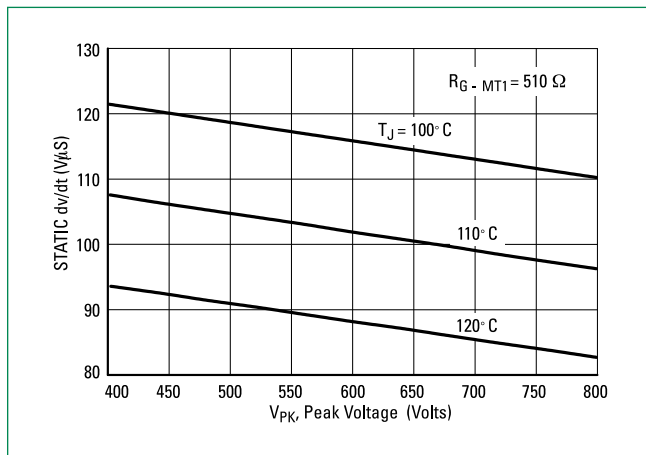


Figure 11. Typical Exponential Static dv/dt Vs. Junction Temperature, MT2(+)

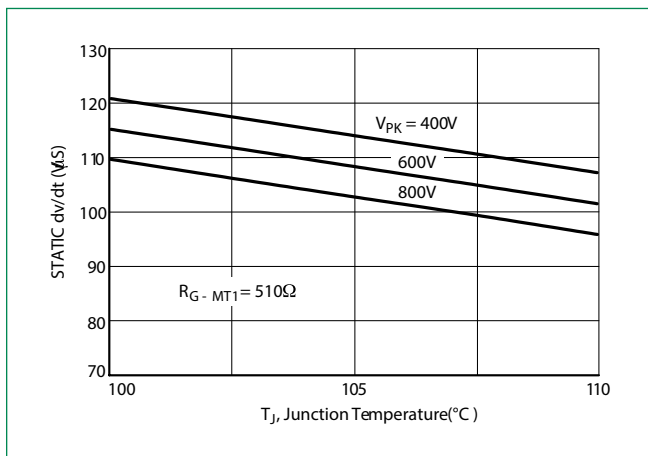
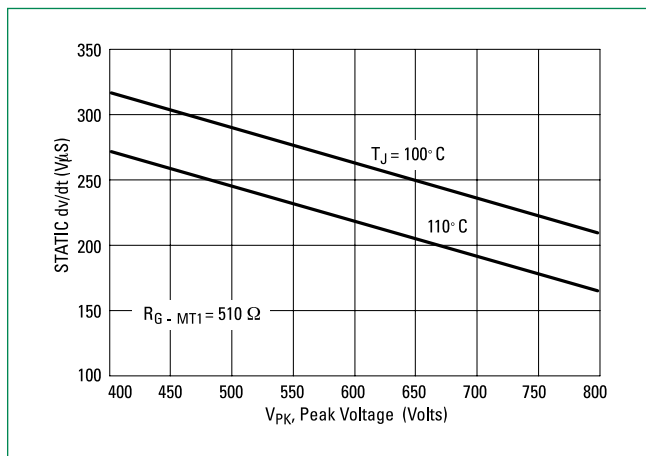


Figure 12. Typical Exponential Static dv/dt Vs. Peak Voltage, MT2(-)



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Figure 13. Typical Exponential Static dv/dt Versus Junction Temperature, MT2(-)

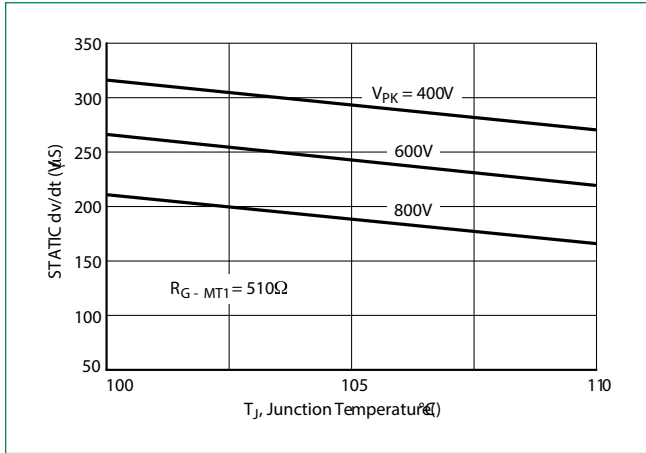


Figure 14. Typical Exponential Static dv/dt Versus Gate-MT1 Resistance, MT2(-)

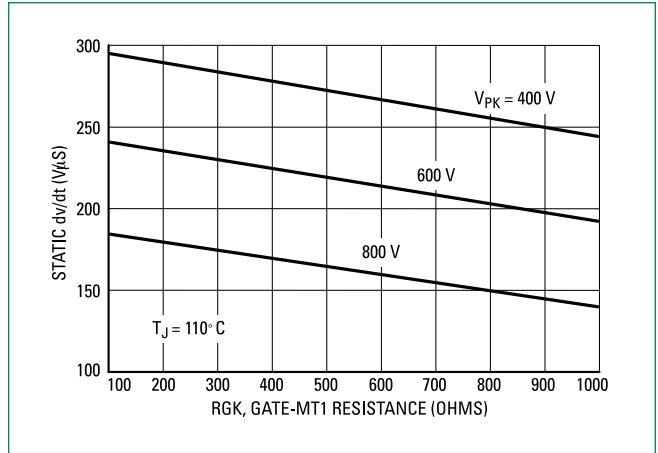


Figure 15. Critical Rate of Rise of Commutating Voltage

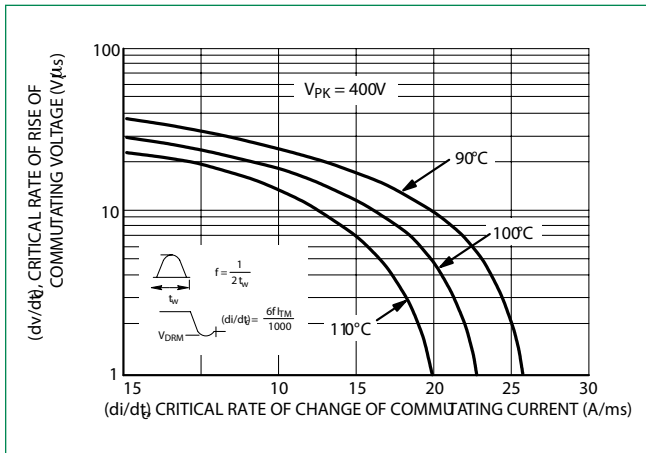
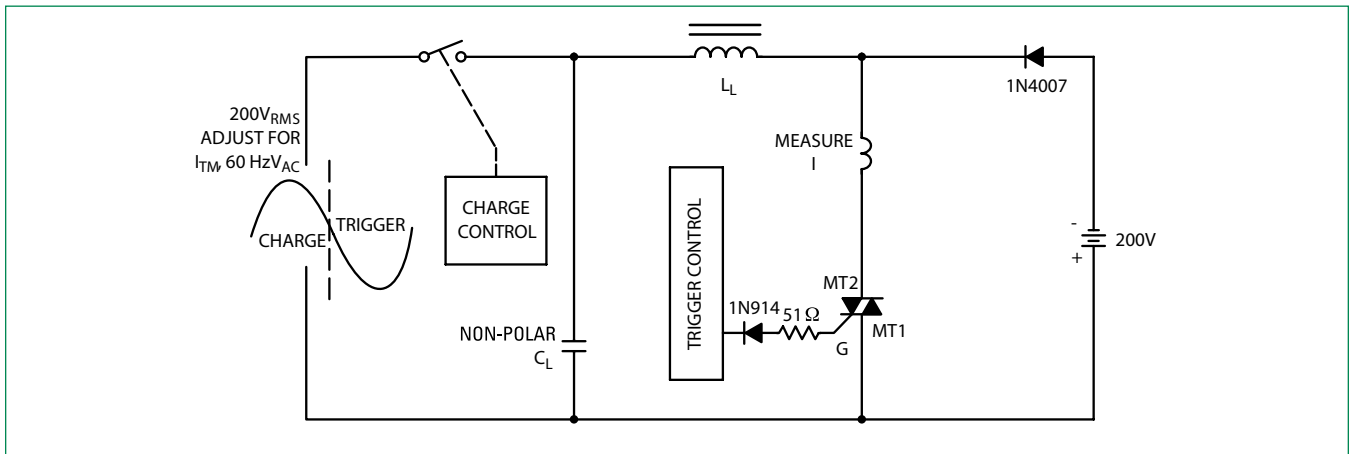


Figure 16. Simplified Test Circuit to Measure the Critical Rate of Rise of Commutating Current (di/dt)



Note: Component values are for verification of rated (di/dt)<sub>c</sub>. See AN1048 for additional information